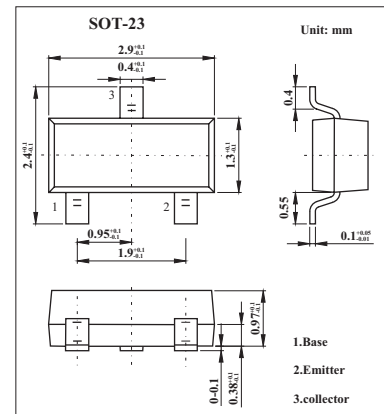


PNP Silicon Epitaxial Transistor

2SA1330

■ Features

- High DC current gain.
- High voltage.

■ Absolute Maximum Ratings $T_a = 25^\circ\text{C}$

Parameter	Symbol	Rating	Unit
Collector-base voltage	V_{CB0}	-200	V
Collector-emitter voltage	V_{CE0}	-200	V
Emitter-base voltage	V_{EB0}	-5	V
Collector current	I_C	-100	mA
Total power dissipation	P_T	200	mW
Junction temperature	T_j	150	$^\circ\text{C}$
Storage temperature	T_{stg}	-55 to +150	$^\circ\text{C}$

2SA1330

■ Electrical Characteristics Ta = 25°C

Parameter	Symbol	Testconditions	Min	Typ	Max	Unit
Collector cutoff current	IcBO	V _{CB} = -200V, I _E =0			-100	nA
Emitter cutoff current	I _{EBO}	V _{EB} = -5V, I _C =0			-100	nA
DC current gain *	h _{FE}	V _{CE} = -10V, I _C = -10mA	90	200	450	
		V _{CE} = -10V, I _C = -50mA	50	195		
Base-emitter voltage *	V _{BE}	V _{CE} = -10V, I _C = -10mA	-0.6	-0.65	-0.7	V
Collector-emitter saturation voltage *	V _{CE(sat)}	I _C = -50mA, I _B = -5mA		-0.21	-0.3	V
Base saturation voltage *	V _{BE(sat)}	I _C = -50mA, I _B = -5mA		-0.8	-1.2	V
Gain bandwidth product	f _T	V _{CE} = -10V, I _E = 10mA		120		MHz
Output capacitance	C _{ob}	V _{CB} = -30V, I _E = 0, f = 1.0MHz		3.6		pF
Turn-on time	t _{on}	I _C = -10mA, I _{B1} = -I _{B2} = -1mA, V _{CC} = -10 V V _{BE(off)} = 2.5V		0.16		μs
Storage time	t _{stg}			1.3		μs
Fall time	t _f			0.18		μs

* Pulse test: t_p ≤ 350 μs; d ≤ 0.02.

■ h_{FE} Classification

Marking	O5	O6	O7
h _{FE}	90~180	135~270	200~450